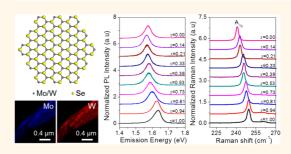
Two-Dimensional Molybdenum Tungsten Diselenide Alloys: Photoluminescence, Raman Scattering, and Electrical Transport

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ABSTRACT Two-dimensional transition-metal dichalcogenide alloys have attracted intense attention due to their tunable band gaps. In the present work, photoluminescence, Raman scattering, and electrical transport properties of monolayer and few-layer molybdenum tungsten diselenide alloys $(Mo_{1-x}W_xSe_2, 0 \le x \le 1)$ are systematically investigated. The strong photoluminescence emissions from $Mo_{1-x}W_xSe_2$ monolayers indicate composition-tunable direct band gaps (from 1.56 to 1.65 eV), while weak and broad emissions from the bilayers indicate indirect band gaps. The first-order Raman modes are assigned by polarized Raman spectroscopy. Second-order Raman modes are



assigned according to its frequencies. As composition changes in $Mo_{1-x}W_xSe_2$ monolayers and few layers, the out-of-plane A_{1g} mode showed one-mode behavior, while B_{2g}^{-1} (only observed in few layers), in-plane E_{2g}^{-1} , and all observed second-order Raman modes showed two-mode behaviors. Electrical transport measurement revealed n-type semiconducting transport behavior with a high on/off ratio (>10⁵) for $Mo_{1-x}W_xSe_2$ monolayers.

KEYWORDS: transition-metal dichalcogenide · semiconductor alloy · tunable band gap · photoluminescence · Raman effect · electrical property

wo-dimensional (2D) semiconductors, such as transition-metal dichalcogenide (TMD) monolayers, have attracted intense interest because of their direct band gaps. 1-5 MoSe₂ and WSe₂ monolayers are two important 2D semiconductors toward light harvesting because of their suitable band gaps (1.44 and 1.54 eV from calculation^{6,7}) for solar cells. Thin-film solar cells based on graphene/MoSe₂, graphene/ WSe₂ heterojunctions have been demonstrated recently, showing a maximum internal efficiency up to 30% with plasmonic enhancing.8 Simulation also shows that graphene/ MoSe₂ and graphene/WSe₂ heterojunctions can achieve a power conversion efficiency up to 1% for these ultrathin solar cells and hence have an ultrahigh power/mass ratio (2500 W/kg, more than 1000 times higher than silicon thin-film solar cells).9 2D transition-metal dichacogenide alloys can have tunable band gaps and CB/VB positions 10-12 and then can be used to fine-tune the optical absorption and fine align the energy levels in these heterostructures for higher performance. 13,14 Here we have mechanically exfoliated Mo_{1-x}W_xSe₂ monolayers and few layers. STEM-EDS showed a homogeneous distribution of different elements in the alloys. Photoluminescence characterization showed composition-dependent direct band gap emissions from 1.56 to 1.65 eV for

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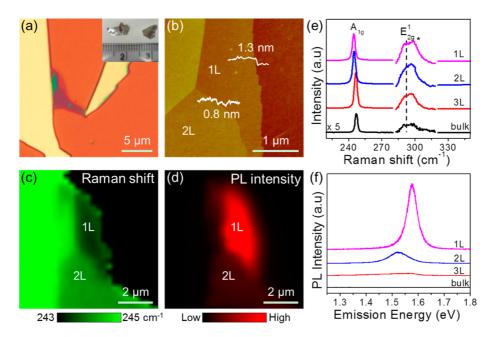


Figure 1. (a) Optical and (b) AFM image of $Mo_{0.67}W_{0.33}Se_2$ sheets. Inset in panel (a) is a photograph of $Mo_{0.67}W_{0.33}Se_2$ single crystals. Mapping images of (c) A_{1g} frequency and (d) PL intensity of the same $Mo_{0.67}W_{0.33}Se_2$ sheets. (e) Raman and (f) PL spectra of $Mo_{0.67}W_{0.33}Se_2$ monolayer (1L, magenta lines), bilayer (2L, blue lines), trilayer (3L, red lines), and bulk samples (black lines). The excitation laser wavelength was 514.5 nm. The Raman peak labeled by * was from the SiO_2/Si substrate.

monolayers. Raman spectroscopic characterization showed one-mode behavior for the A_{1g} mode and two-mode behaviors for first-order modes $E_{2g}^{\ 1}$ and $B_{2g}^{\ 1}$ and the observed second-order Raman modes. Field-effect transistors fabricated on monolayers showed n-type transport with high on/off ratios (>10⁵).

RESULTS AND DISCUSSION

 $Mo_{1-x}W_xSe_2$ monolayers consist of two Se atomic layers and a sandwiched metal (Mo, W) atom layer. 15,16 Figure 1a shows an optical image of exfoliated $Mo_{0.67}W_{0.33}Se_2$ (x=0.33) flakes with monolayer and bilayer regions. The red channel contrasts of the monolayer and bilayer regions are $\sim 10\%$ and $\sim 20\%$, respectively. 17 The inset in Figure 1a is a photograph of $Mo_{0.67}W_{0.33}Se_2$ single crystals. The atomic force microscopy (AFM) image of this alloy sheet is shown in Figure 1b, showing a height of about 1.3 nm for the monolayer, which is larger than the theoretical interlayer distance in $Mo_{0.67}W_{0.33}Se_2$ bulk materials (~ 0.6 nm). This phenomenon is due to the instrumental offset (~ 0.5 nm) 18,19 and is commonly observed in AFM imaging of transition-metal dichalcogenide monolayers $^{20-22}$

For $Mo_{0.67}W_{0.33}Se_2$ alloy sheets, the PL image shows that emission from monolayers is stronger than that from bilayers, while there is much weaker emission from the thicker and bulk materials (Figure 1d,f), suggesting transition from indirect band gap to direct band gap when $Mo_{0.67}W_{0.33}Se_2$ thinned from bulk to monolayer. From monolayer to bulk $Mo_{0.67}W_{0.33}Se_2$ alloys, the first-order Raman peak A_{1g} mode is stiffened from 243.4 to 245.6 cm⁻¹, while the E_{2g}^{1} mode is slightly softened from 288.5 to 287.7 cm⁻¹ (Figure 1c,e). The

assignment of the E_{2g}^{-1} mode is confirmed by polarized Raman spectroscopy (Figure S2). Note that the correct Raman notation should be A_1' and E' for odd layers, and A_{1g} and E_g for even layers. Here for simplicity, the notations of Raman modes A_{1g} and E_{2g}^{-1} (correct for bulk materials) are used for $Mo_{1-x}W_xSe_2$ monolayers and few layers in this article. Similar to that in $MoSe_2$ and WSe_2 , the A_{1g} mode shifted to higher frequency with increasing sample thickness. Raman frequency variation within the monolayer and bilayer region is less than $0.3~cm^{-1}$, indicating homogeneous composition in the micrometer scale. Raman and PL spectra of $Mo_{1-x}W_xSe_2$ with other W compositions (Figures S7—S16) showed similar characteristics to that in $Mo_{0.67}W_{0.33}Se_2$, *i.e.*, much stronger PL emission from monolayers, and stiffening of A_{1g} and slight softening of E_{2g}^{-1} as the layer number increases.

Further high-angle annular dark filed (HAADF) scanning transmission electron microscopy (STEM) with EDS capability was used for mapping element distributions in nanometer scales. Figure 2a shows a STEM-HAADF image of as-grown ${\rm Mo}_{0.47}{\rm W}_{0.53}{\rm Se}_2$ few layers. The inset in Figure 2a is an atomically resolved image to reveal its honeycomb atom arrangement. Figure 2b shows the EDS spectrum of the ${\rm Mo}_{0.47}{\rm W}_{0.53}{\rm Se}_2$ sheet with well-resolved Mo, W, and Se peaks. The EDS mapping (Figure 2c—e) revealed a uniform distribution of Mo, W, and Se in the sample.

PL measurements on $Mo_{1-x}W_xSe_2$ monolayers with different W compositions showed tunable band gap exciton emissions (Figure 3a). As W composition x increases, the PL emission shows a bowing effect, in which emission energy first red shifts to a minimum value at around x = 0.2-0.3 and then monotonically

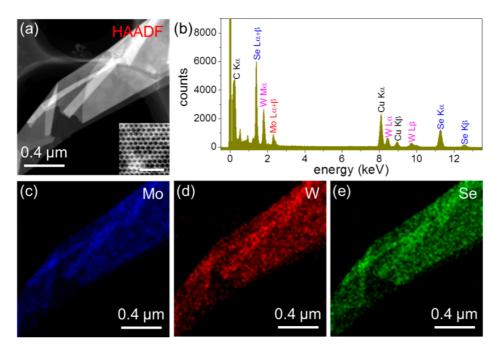


Figure 2. (a) HAADF STEM image and (b) EDS spectrum of $Mo_{0.47}W_{0.53}Se_2$ flakes. Inset in (a) is a high-resolution STEM image, and the scale bar is 3 nm. (c) Mo, (d) W, and (e) Se element mapping image for the same sheet.

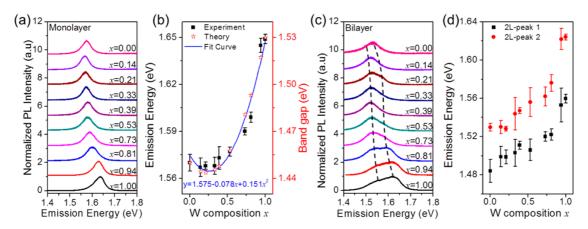


Figure 3. Composition-dependent (a) PL spectra and (b) PL emission energies of $Mo_{1-x}W_xSe_2$ monolayer alloys. The blue line in (b) is the parabola fitting for the experimental emission energy. Composition-dependent (c) PL spectra and (d) PL emission energies of $Mo_{1-x}W_xSe_2$ bilayers. The black dashed lines in (c) show the emission energy shift of the two peaks. The excitation laser wavelength was 514.5 nm.

blue shifts.²⁶ This result can be attributed to the linearity of VB and deviation from linearity of the CB energy variation with the W composition.²⁷ Therefore, the band gap emission of the $Mo_{1-x}W_xSe_2$ monolayers can be continuously tuned from 1.56 eV (reached at x = 0.21) to 1.65 eV (reached at x = 1). The PL emission bowing in $Mo_{1-x}W_xSe_2$ monolayer alloys can be described by the following function:^{26,27}

$$E_{PL, Mo_{1-x}W_xSe_2} = xE_{PL, WSe_2} + (1-x)E_{PL, MoSe_2} - bx(1-x)$$
(1)

where b is the bowing parameter. Fitting the experimental results with eq 1 gives a bowing parameter of 0.151 eV (Figure 3b), which is well consistent with the calculated results (b = 0.14 eV).²⁷

For bilayer $MoSe_2$ and WSe_2 , the energy difference between the indirect and direct transitions is small (~20 meV), and then both emissions can be observed in experiments. The PL spectra of $Mo_{1-x}W_xSe_2$ bilayers with different W composition also shows multiple components, which can be assigned to direct and indirect band gap exciton emissions (Figure 3c). The emission peak position *versus* W composition is presented in Figure 3d. Further theoretical simulation is needed to elucidate the observed composition-dependent behaviors in $Mo_{1-x}W_xSe_2$ bilayers.

To further confirm the assignment of Raman modes in $Mo_{1-x}W_xSe_2$ alloys, polarized Raman spectroscopy was carried out. For monolayer $MoSe_2$, the A_{1g} and E_{2g}^{-1} modes are centered at 240.1 and 287.1 cm⁻¹,

respectively. 1,30,31 However, for the WSe2 monolayer, there are conflicting reports on the assignment of A_{1a} and E_{2q} modes. Theoretical studies have suggested that A_{1g} and E_{2g}^{-1} are degenerate at $\sim\!250~\text{cm}^{-1}$ in the few-layer WSe₂, ^{32,33} while several experimental studies have assigned the Raman peaks at 249.6 and $260.8 \,\mathrm{cm}^{-1}$ to $\mathrm{E_{2q}}^{1}$ and $\mathrm{A_{1q}}$ phonon modes, 28,29,34 respectively. In our work, monolayer WSe₂ (Figure S4a) exhibits a prominent Raman mode at \sim 249.6 cm⁻¹ and a weak peak at \sim 261.2 cm⁻¹ under both parallel (Z(XX) \bar{Z}) and cross (Z(YX)Z) polarization conditions with 514.5 nm excitation. This indicates that the 261 cm⁻¹ peak should not be A_{1a} mode. When the thickness increases from monolayer to bulk, the 249.6 cm⁻¹ peak (Figure S4a) splits into two peaks at \sim 248.0 and 251.2 cm⁻¹ (Figure S 4d), in which the 251.2 cm⁻¹ peak is active only under parallel polarization configuration, and the 248.0 cm⁻¹ peak is active at both parallel and cross-polarization configurations. These results suggest that the 251.2 cm⁻¹ peak should be A_{1g} mode and the 248.5 cm⁻¹ peak should be E_{2q} mode. A similar thickness and polarization dependence of the phonon modes are observed for WSe2 when the incident laser wavelength is 632.8 nm (Figure S4e-h). Therefore, for monolayers, the 249.6 cm⁻¹ peak can be assigned to the A_{1q} and E_{2q}^{-1} modes, and the 261.2 cm⁻¹ peak can be assigned to a second-order Raman peak.

When TMDs are thinned from 3D crystals to 2D crystals,²⁵ some Raman inactive modes in the bulk may become Raman active in the few layers because of the reduced symmetry [from D_{6h} to D_{3h} (odd layers) or D_{3d} (even layers)]. Theoretical studies have predicted that the out-of-plane vibrational mode B_{2a} (correct notation is A'_1^2 for odd layers and A_{1q}^2 for even layers), which is Raman inactive in bulk WSe2 and MoSe₂, becomes Raman active when the thickness thins to a few layers due to the break of the symmetry selection rules in the resonant scattering processes.³⁵ The polarized and unpolarized Raman spectra of MoSe₂ and WSe₂ with different thicknesses are shown in Figure 4 and Figures S7, S16. The B_{2q}¹ mode, which lies around 353 and 309 cm⁻¹ for MoSe₂ and WSe₂, respectively, can be detected only under parallel polarization in few layers. This Raman peak slightly shifts to lower frequency as the layer number increases, which can be attributed to the surface effects.35 Additionally, the E_{1a} mode (corresponding notations are E''^2 and E_{α}^2 for odd layers and even layers, respectively), which results from the opposite moving of the two Se atoms parallel to the layer planes, 36 was observed in few-layer MoSe₂ (Figures 4 and S16) under both parallel and cross-polarization configurations. Note, the notations of Raman modes in bulk materials are used for $Mo_{1-x}W_xSe_2$ monolayers and few layers in this article for simplicity.

The frequencies of second- and higher-order Raman modes should be equal to the sum of frequencies of

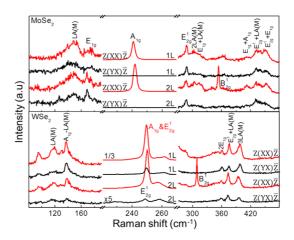


Figure 4. Polarized Raman spectra of $MoSe_2$ (top) and WSe_2 (bottom) monolayers and bilayers in the range 80-480 cm $^{-1}$ under parallel ($Z(XX)\bar{Z}$, red lines) and cross ($Z(YX)\bar{Z}$, black lines) polarization configurations. Assignment of the first- and second-order Raman modes is marked at the top of the spectra. For clarity, the spectra in the range 220-270 cm $^{-1}$ are multiplied by a factor in magnitude labeled on the corresponding spectra. The excitation laser wavelength was 514.5 nm.

the involved phonon modes. $^{37-40}$ According to the above rules, the assignment of the relatively weak second- and higher-order Raman peaks in MoSe $_2$ and WSe $_2$ has been carried out (Figure 4). The second-order Raman peaks also showed polarization-dependent intensity. For few-layer MoSe $_2$, the overtone mode 2LA(M) and combination mode $E_{1g}+A_{1g}$ can be observed only in the parallel polarization configuration, while other combination modes can be detected under both parallel and cross-polarization configurations. However, the combination modes of few-layer WSe $_2$ showed different intensities on different polarization configurations.

Figure 5a,b show unpolarized Raman spectra of $Mo_{1-x}W_xSe_2$ monolayers with different W composition x and the corresponding composition-dependent Raman frequencies. Similar to that of $Mo_{1-x}W_xS_2$ alloys, 41,42 the out-of-plane A_{1q} and in-plane E_{2q} modes show one-mode and two-mode behaviors, respectively. The A_{1q} mode continuously shifts from 240.1 to 249.3 cm^{-1} when the W composition x increases from 0 to 1, which is close to a linear dependence on the W composition. As shown in Figure 5a, the MoSe₂-like E_{2q}¹ shifts to lower frequency as the W composition increases. In addition, the secondorder Raman peaks also shift and showed two-mode behaviors as the W composition changes; that is, there are two branches of $E_{2q}^{-1}+LA(M)$ mode: one branch is related to $MoSe_2$ (at \sim 432.7 cm⁻¹ in $MoSe_2$) and the other branch is related to WSe₂ (at \sim 373.6 cm⁻¹ in WSe_2). When the W composition x increases, all MoSe₂-like second-order Raman peaks slightly shift to lower frequencies. WSe2-like Raman peaks showed different shift directions: WSe₂-like A_{1q}-LA(M) and 2E_{1q} modes upshift, 3LA(M) downshifts, and $E_{2q}^{-1}+LA(M)$ has almost no shift.

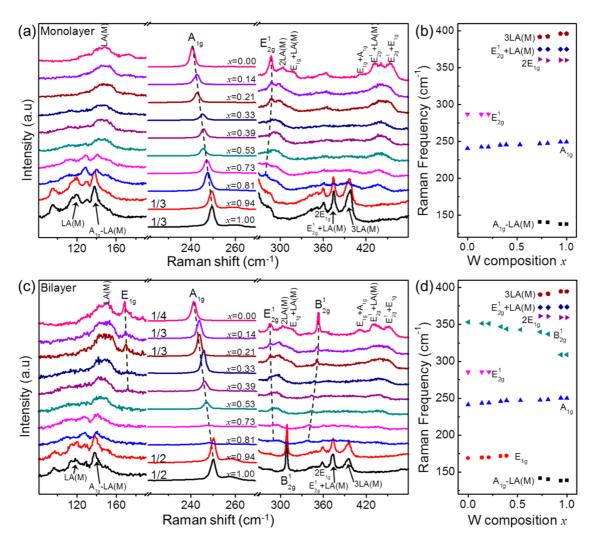


Figure 5. (a) Raman spectra of $Mo_{1-x}W_xSe_2$ monolayers with different W composition x in the range $80-480~cm^{-1}$. (b) Composition-dependent Raman frequencies of $Mo_{1-x}W_xSe_2$ monolayer alloys. (c) Raman spectra of $Mo_{1-x}W_xSe_2$ bilayers with different W composition x. (d) Composition-dependent Raman frequencies of $Mo_{1-x}W_xSe_2$ bilayer alloys. All the spectra are calibrated with the $520~cm^{-1}$ Raman peak from the Si substrate. The black dashed lines in (a) and (c), guides for the eye, show the frequency shift of the first-order Raman modes with different W compositions x. For clarity, the intensity of spectra in the range $220-270~cm^{-1}$ is magnified by a factor labeled on the corresponding spectra. The excitation laser wavelength was 514.5~nm.

Raman spectra and Raman frequency shift of $Mo_{1-x}W_xSe_2$ bilayers with different W composition are shown in Figure 5c,d. Similar to that in monolayers, the A_{1g} mode shows one-mode behavior, while other modes show two-mode behaviors. When the W composition increases, the E_{1g} mode of $MoSe_2$ slightly shifts to higher frequency, while the $MoSe_2$ -like B_{2g}^{-1} shifts to lower frequency. The $MoSe_2$ -like B_{2g}^{-1} mode can be observed for x in the range 0-0.81, while the WSe_2 -like B_{2g}^{-1} mode can be observed only for the last two composition alloys (x=0.94 and 1.00).

In addition, the modified random element isodisplacement (MREI) model, 41 which is based on the assumption of isodisplacement of the same atoms and the randomness distribution of Mo/W atoms, can be used to fit the composition-dependent Raman frequencies of the A_{1g} mode for $Mo_{1-x}W_xSe_2$ monolayers and bilayers (Figure S6). The composition-dependent A_{1g} frequency,

analyzed using the MREI model, can be expressed as

$$\omega_{A_{1g}} = \left[\frac{(1-x)F_1 + xF_2}{m_{Se}} \right]^{1/2}$$

$$= \left[\frac{(1-x)(1-\theta x)F_{10} + x(1-\theta x)F_{20}}{m_{Se}} \right]^{1/2}$$
 (2)

where $m_{\rm Se}$ is the atomic mass of Se; F_1 and F_2 are the force constants of Mo—Se and W—Se interactions, respectively; F_{10} and F_{20} are limiting values of F_1 and F_2 as x is reduced to 0; and θ is a parameter that is associated with the variation of force constant in the alloys. The fitting result gives a more accurate composition-dependent frequency shift of the A_{1q} mode,

$$\omega_{A_{1g}}^{1L} = 240.1(1 + 0.057x - 0.023x^2)$$
 (3)

$$\omega_{A_{10}}^{2L} = 241.0(1 + 0.052x - 0.018x^2) \tag{4}$$

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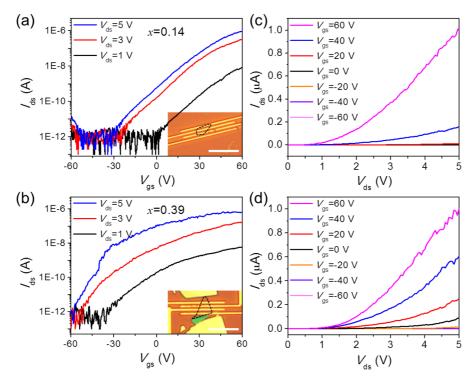


Figure 6. (a, b) Transfer curves ($I_{ds} - V_{gs}$) under different source—drain voltage and (c, d) output curves ($I_{ds} - V_{ds}$) under different bottom gate voltage of Mo_{1-x}W_xSe₂ monolayer FETs for (a, c) x = 0.14 and (b, d) x = 0.39. Insets in (a) and (b) are the optical images of the devices, and the scale bar in the insets is 10 μ m. The black dashed lines in the insets are the profiles of the monolayer samples.

which can be used to quantify the W composition for $Mo_{1-x}W_xSe_2$ with unknown composition.

Field effect transistors (FETs) were also fabricated on $Mo_{1-x}W_xSe_2$ monolayers. Figure 6 shows the typical transfer and output curves for $Mo_{1-x}W_xSe_2$ monolayers (more device data in Figure S17). All $Mo_{1-x}W_xSe_2$ monolayer FETs exhibited n-type semiconducting transport behavior with high on—off ratios (>10⁵). The field effect carrier mobility of $Mo_{1-x}W_xSe_2$ monolayer devices can be calculated from the transfer curves based on the following equation:

$$\mu_{FE} = \frac{\mathrm{d}I_{ds}}{\mathrm{d}V_{gs}} \frac{L}{W} \frac{1}{C_{\mathrm{g}}V_{\mathrm{ds}}} \tag{5}$$

where L and W are channel length and width of the device, respectively; $C_{\rm g}$ is the gate capacitance of the dielectric layer; $I_{\rm ds}$ is the drain—source current; and $V_{\rm gs}$ is the gate voltage. $dI_{\rm ds}/dV_{\rm gs}$ can be calculated from the slope of the transfer curves. The calculated mobility of $Mo_{1-x}W_xSe_2$ monolayer FETs with x=0.14, 0.33, 0.39, and 1.00 was about $0.215, 0.129, 7.8 \times 10^{-2}$, and $2.97 \times 10^{-3}~{\rm cm}^2{\rm V}^{-1}~{\rm s}^{-1}$, respectively. The low mobility for the $Mo_{1-x}W_xSe_2$ monolayer FETs resulted from the poor contact between the electrode (Ti/Au) and the monolayers. The onset threshold gate voltage shifts to more

negative values at higher W compositions, indicating that the valence and conduction band shift as the W composition changes.

CONCLUSION

In conclusion, we have studied PL, Raman, and electrical properties on $Mo_{1-x}W_xSe_2$ (0 $\leq x \leq 1$) monolayers and few layers. The Mo_{1-x}W_xSe₂ monolayers exhibited strong PL emission, indicating the direct band gap nature, while the bilayers and few layers are indirect band gap semiconductors. Composition-dependent PL emission showed tunable band gaps for the $Mo_{1-x}W_xSe_2$ monolayer alloys (from \sim 1.56 to \sim 1.65 eV). First- and second-order Raman modes were observed in the frequency range 80-480 cm⁻¹. The assignment of first-order Raman modes is confirmed using polarized Raman spectroscopy, and the second-order modes are assigned based on its frequencies. Composition-dependent Raman frequencies of the A_{1a} mode are fitted by the MREI model. Field effect transistors based on the monolayer alloys have shown n-type transport behavior with a high on/off ratio (>10⁵). The composition- and layer-dependent properties of 2D Mo_{1-x}W_xSe₂ alloys make it promising for future nanoelectronics, optoelectronics, and solar cells.

EXPERIMENTAL SECTION

 $Mo_{1-x}W_xSe_2$ single crystals were grown by the chemical vapor transport method. The W composition in $Mo_{1-x}W_xSe_2$

alloys was determined by energy-dispersive X-ray spectroscopy (EDX), which is shown in the Supporting Information (Figure S1).

 ${\rm Mo_{1-x}W_xSe_2}$ monolayer and few-layer alloy samples were prepared by micromechanical exfoliation of ${\rm Mo_{1-x}W_xSe_2}$ single crystals on ${\rm SiO_2/Si}$ (300 nm thick oxide) substrates using Scotch tape. The monolayer and few-layer ${\rm Mo_{1-x}W_xSe_2}$ samples were distinguished by a combination of optical microscopy (on an Olympus BX51 microscope) and atomic force microscopy (on a Veeco Dimension 3100 with tapping-mode).

PL and Raman spectra were collected on a JY Horiba HR800 Raman system with 632.8 and 514.5 nm lasers, a $100 \times$ objective (NA = 0.9, corresponding XY resolution of \sim 1 μ m), and an 1800 lines/mm grating (corresponding a spectral resolution of $\sim\!\!0.6~\text{cm}^{-1})$. The laser power was kept below 0.5 mW to avoid possible heating effect. In the polarization-dependent Raman experiments, the parallel polarization, i.e., Z(XX)Z configuration, was measured by placing an analyzer between edge filter and detector, and the polarization direction of the scattered light was parallel to that of the incident laser. The cross-polarization, i.e., $(Z(YX)\overline{Z})$ configuration, was measured by placing a half-wave plate in the laser path and placing an analyzer between the edge filter and the detector in the signal path. PL and Raman mapping experiments were taken by using an XYZ microscope stage. The intensity and peak position of the PL and Raman peaks were obtained by fitting them with Gaussian and Lorentzian functions, respectively.

HAADF-STEM imaging and STEM-EDS mapping were conducted on an FEI Titan Chemi-STEM operated at 80 kV. This microscope was equipped with a Bruker Super-X EDS system with ultralarge windows and short working distance for X-ray detection. A typical probe current of 80 pA was used for the HAADF imaging and 200 pA for EDS mapping to obtain a high enough X-ray signal.

Field effect transistors based on the monolayer $Mo_{1-x}W_xSe_2$ alloys were fabricated by standard electron-beam lithography and thermal evaporation of 5 nm Ti and 50 nm Au. Electrical measurements were performed on an Agilent B1500A semiconductor device analyzer in a vacuum (Janis ST500 probe station, $\sim 10^{-5}$ Torr).

Conflict of Interest: The authors declare no competing financial interest.

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Supporting Information Available: EDX characterization results of $Mo_{1-x}W_xSe_2$ single crystals, schematics of atomic displacements of the first-order modes, polarized Raman spectra of WSe₂ with different layer numbers under 514.5 and 632.8 nm laser excitation, polarized Raman spectra of $Mo_{0.77}W_{0.83}Se_2$ and $Mo_{0.79}W_{0.21}Se_2$, composition-dependent A_{1g} frequency in monolayer and bilayer $Mo_{1-x}W_xSe_2$ alloys using the MREI model, and optical, AFM, PL emission, and Raman spectra of $Mo_{1-x}W_xSe_2$ with different W composition x. This material is available free of charge via the Internet at http://pubs.acs.org.

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